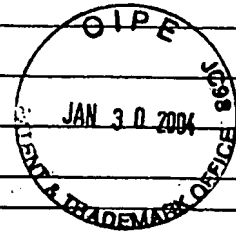


INFORMATION DISCLOSURE CITATION

Atty. Docket No.	4329.3122	Appln. No.	10/650,013
Applicant	Fukuhara et al.		
Filing Date	August 28, 2003	Group:	Not assigned



U.S. PATENT DOCUMENTS

Examiner Initial*	Document Number	Issue Date	Name	Class	Sub Class	Filing Date If Appropriate

FOREIGN PATENT DOCUMENTS

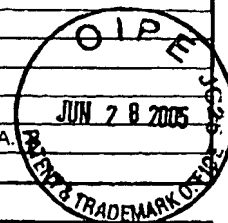
Document Number	Publication Date	Country	Class	Sub Class	Translation Yes or No

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

/IA/	Kazuya Sato et al., "Measurement of effective source shift using a grating-pinhole mask," SPIE, vol. 3679, pp. 99-107 (March 1999).

Examiner	/Isiaka Akanbi/	Date Considered	06/25/2007
*Examiner:	Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.		
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IDS Form PTO/SB/08: Substitute for form 1449A/PTO		Complete if Known	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use as many sheets as necessary)		Application Number	10/650,013
		Filing Date	August 28, 2003
		First Named Inventor	Kazuya FUKUHARA
		Art Unit	2877
		Examiner Name	Rosenberger, Richard A.
Sheet 1 of 1	Attorney Docket Number	04329.3122-00000	



U.S. PATENTS AND PUBLISHED U.S. PATENT APPLICATIONS					
Examiner Initials	Cite No. ¹	Document Number	Issue or Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code ² (if known)			

Note: Copies of the U.S. Patent Documents are not Required in IDS filed after October 21, 2004

FOREIGN PATENT DOCUMENTS						
Examiner Initials	Cite No. ¹	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	Translation ⁶
		Country Code ³ Number ⁴ Kind Code ⁵ (if known)				
/IA/		CN 1136708 A	11-27-1996			N

NON PATENT LITERATURE DOCUMENTS			
Examiner Initials	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	Translation ⁶
/IA/		Notification of the First Office Action from the State Intellectual Property Office of the People's Republic of China dated April 8, 2005, in patent application no. 031560024, and English translation	Y

Examiner Signature	/Isiaka Akanbi/	Date Considered	06/25/2007
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

IDS Form PTO/SB/08: Substitute for form 1449A/PTO <h2 style="text-align: center;">INFORMATION DISCLOSURE STATEMENT BY APPLICANT</h2> <p style="text-align: center;">(Use as many sheets as necessary)</p>				Complete if Known	
				Application Number	10/650,013
				Filing Date	August 28, 2003
				First Named Inventor	Kazuya FUKUHARA
				Art Unit	2877
				Examiner Name	Akanbi, Isiaka O.
				Confirmation No.:	6468
				Attorney Docket Number	04329.3122
Sheet	1	of	1		



U.S. PATENTS AND PUBLISHED U.S. PATENT APPLICATIONS					
Examiner Initials	Cite No. ¹	Document Number	Issue or Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code ² (if known)			

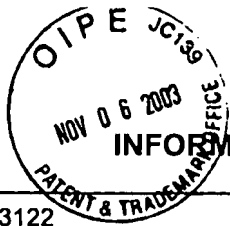
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FOREIGN PATENT DOCUMENTS						
Examiner Initials	Cite No. ¹	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	Translation ⁵
		Country Code ³ Number ⁴ Kind Code ⁵ (if known)				
/IA/		JP 03-065623	03-20-1991			No
/IA/		JP 2000-021732	01-21-2000			No
/IA/		JP 2002-083761	03-22-2002			No

NON PATENT LITERATURE DOCUMENTS			
Examiner Initials	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	Translation ⁶
/IA/		Notification of Reasons for Rejection, mailed January 30, 2007, in Japanese counterpart Application No. 2002-255210	Yes

Examiner Signature	/Isiaka Akanbi/	Date Considered	06/25/2007
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OMB No. 0651-0011

INFORMATION DISCLOSURE CITATION

Atty. Docket No.	4329.3122	Appln. No.	10/650,013
Applicant	Fukuhara et al.		
Filing Date	August 28, 2003	Group:	Unknown

U.S. PATENT DOCUMENTS

Examiner Initial*	Document Number	Issue Date	Name	Class	Sub Class	Filing Date If Appropriate
/IA/	6,317,198	11/13/01	Sato et al.			
/IA/	6,048,651	4/11/00	Brunner et al.			
/IA/	5,973,771	10/26/99	Hibbs et al.			

FOREIGN PATENT DOCUMENTS

Document Number	Publication Date	Country	Class	Sub Class	Translation Yes or No

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

/IA/	Kirk et al., "Pupil Illumination; in situ measurement of partial coherence," SPIE, 3334:281-288

Examiner	/Isiaka Akanbi/	Date Considered	06/25/2007
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